

Ottlite Technologies Inc.

TEST REPORT

SCOPE OF WORK

SAR Assessment– Q50

REPORT NUMBER

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DOCUMENT CONTROL NUMBER

RF Exposure

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Test Report

Applicant : Ottlite Technologies Inc.
1715 N Westshore Blvd, Suite 950, Tampa, FL
33607,USA

Sample Description

Product : LED Table Lamp with Wireless Charging
Model No. : Q50

Electrical Rating : N/A

Date Received : 23 November 2021
Date Test Conducted : 30 November 2021 to 08 December 2021

Test Requested : Test for compliance with CFR 47 part 1
Test Method : Environmental evaluation and exposure limit according to FCC CFR 47 part 1, 1.1307(c) and (d), 1.1310 KDB 680106 D01 RF Exposure Wireless Charging App v03r01

Test Result : Pass
Conclusion : When determining of test conclusion, measurement uncertainty of tests have been considered.

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Approved By:

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Date: 14 February 2022

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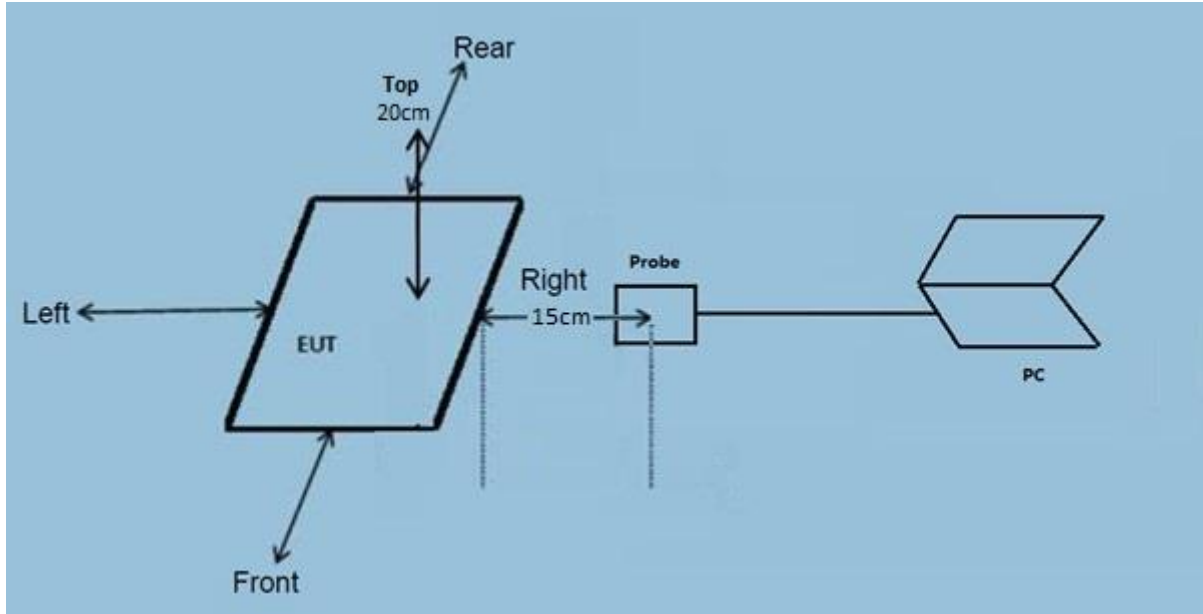
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Test Report

Test Setup Configuration



Note

- The RF exposure test is performed in the shield room.
- The test distance is between the edge of the charger and the geometric centre of probe.

Test Equipment List

Equipment No.	Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Due Date
SZ186-04	Electric and Magnetic Field Analyzer	Narda	EHP-50F	510WY90119	2021-07-20	2022-07-20

This product was tested in the following configuration:

Description	Manufacturer	Detail
Mobile phone	NIL (Provided by Intertek)	Manufacturer: Samsung Model: S7
Class 2 Power Supply	DongGuan Toyee Electronics Technology Co., Ltd. (Provided by Client)	Model: TY0500200A1mn Input: 100-240Vac 50/60Hz 0.4A Output: 5Vdc 2.0A

Justification

Pertest mode	Description
Mode 1	Standby mode
Mode 2	Mobile phone is charging at 1% battery power
Mode 3	Mobile phone is charging at 50% battery power
Mode 4	Mobile phone is charging at 99% battery power

The EUT was powered by an adapter with 120V/60Hz input during the test. The test system was pre-scanning tested based on the consideration of following EUT operation mode. Only the worst-case data was shown in this report.

Reference Limit:

Environmental evaluation and exposure limit according to FCC CFR 47 part 1, 1.1307(c) and (d), 1.1310

According to FCC 1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation.

LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency Range (MHz)	Electric Field strength (V/m)	Magnetic Field Strength (A/m)	Power Density (mW/cm ²)	Average Time (minutes)
(A) Limits for Occupational/Controlled Exposure				
0.3 – 3.0	614	1.63	(100) *	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3 – 1.34	614	1.63	(100) *	30

Note: * = Plane wave equivalent power density

Test Result:

During test, the mobile handset is being charged.

Worst Case Operating Mode: Mode 2

Test Result for wireless power transmit part:

H-Field Strength at 15 cm surrounding the EUT and 20cm above the top surface of the EUT

Frequency Range (MHz)	EUT Operation mode	Probe Position Front (A/m)	Probe Position Rear (A/m)	Probe Position Left (A/m)	Probe Position Right (A/m)	Probe Position Top (A/m)	Limits (A/m)
0.113-0.205	1% Battery Level	0.0192	0.0193	0.0203	0.0201	0.0160	1.63
0.113-0.205	50% Battery Level	0.0194	0.0202	0.0198	0.0203	0.0176	1.63
0.113-0.205	99% Battery Level	0.0184	0.0190	0.0210	0.0196	0.0204	1.63
0.113-0.205	Stand-by	0.0192	0.0167	0.0167	0.0193	0.0192	1.63

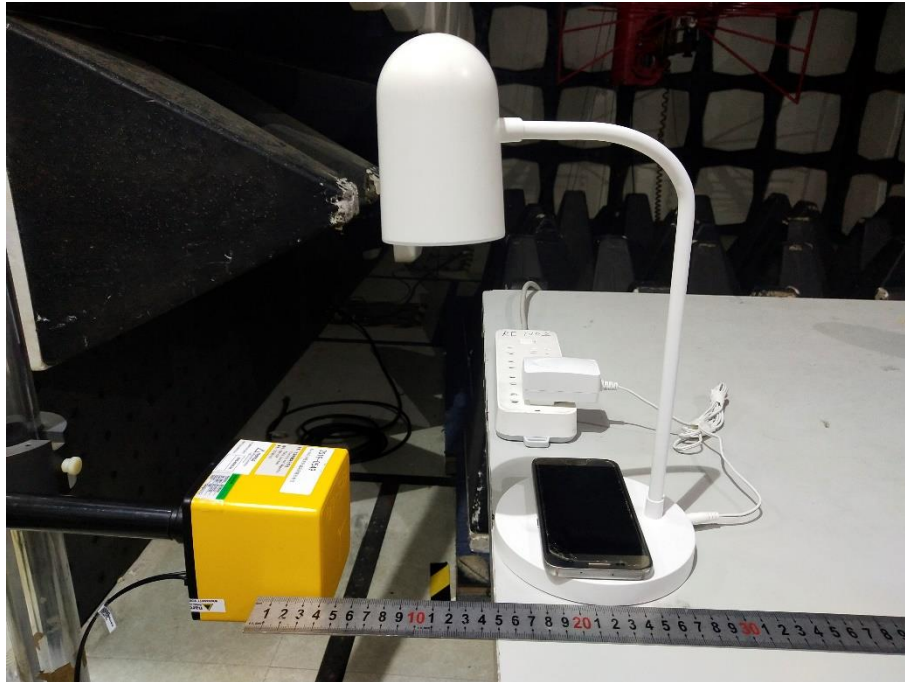
E-Field Strength at 15 cm surrounding the EUT and 20cm above the top surface of the EUT

Frequency Range (MHz)	EUT Operation mode	Probe Position Front (V/m)	Probe Position Rear (V/m)	Probe Position Left (V/m)	Probe Position Right (V/m)	Probe Position Top (V/m)	Limits (V/m)
0.113-0.205	1% Battery Level	0.3619	0.2874	0.3018	0.3205	0.2786	614
0.113-0.205	50% Battery Level	0.3412	0.3512	0.3256	0.3026	0.2994	614
0.113-0.205	99% Battery Level	0.2976	0.3018	0.3104	0.3044	0.3578	614
0.113-0.205	Stand-by	0.1746	0.1738	0.1809	0.1916	0.1752	614

Configuration photo of the test:

H-Field & E-Field Strength test photos

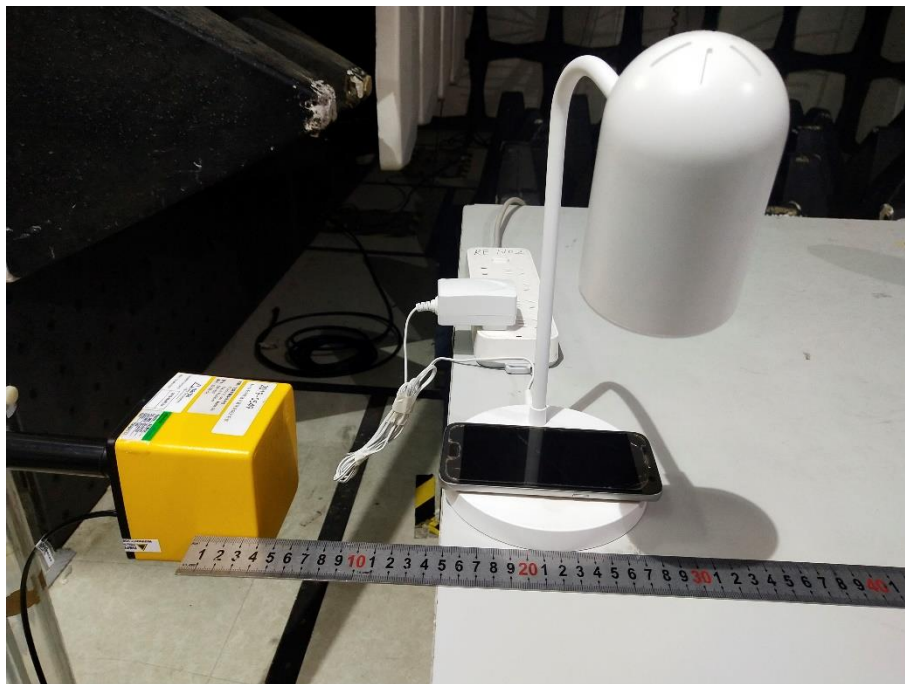
Front



Rear



Left



Right



Top



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